Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10564287	FUCHIKAMI, RYUJI
	Examiner	**Art Unit**
	Ryan D Coyer	2197

SEARCHED

Class	Subclass	Date	Examiner
714	38	10/3/2011	RDC
717	130-131	10/3/2011	RDC
726	22-25 (keyword limited)	10/3/2011	RDC

SEARCH NOTES

Search Notes	Date	Examiner
PLUS Search	10/3/2011	RDC
EAST Search	10/3/2011	RDC
Inventor Name & Double Patenting Search	10/3/2011	RDC
NPL Search - IEEE, ACM, Google Scholar; Keywords: buffer overflow, illegal memory access detection, memory security, stack smashing	10/3/2011	RDC

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner